

DUAL FREQUENCY CRYSTAL OSCILLATOR (XO) (10 MHz TO 1.4 GHz)

Features

- Available with any-frequency output frequencies from 10 MHz to 945 MHz and select frequencies to 1.4 GHz
- 2 selectable output frequencies
- 3rd generation DSPLL® with superior jitter performance
- 3x better frequency stability than SAW-based oscillators
- Pin 1 output enable (OE)
- Internal fixed crystal frequency ensures high reliability and low aging
- Available CMOS, LVPECL, LVDS, and CML outputs
- 3.3, 2.5, and 1.8 V supply options
- Industry-standard 5 x 7 mm package and pinout
- Pb-free/RoHS-compliant

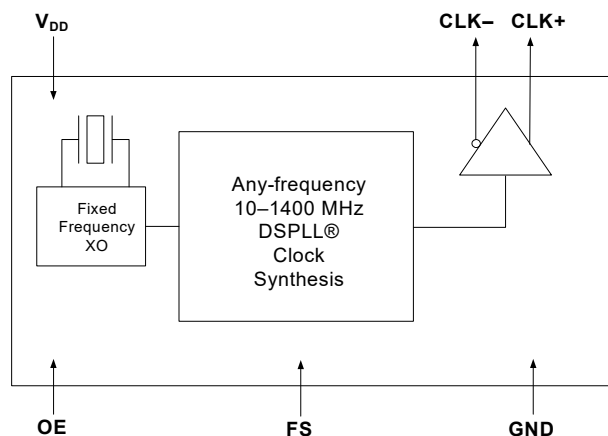
Applications

- SONET/SDH
- Networking
- SD/HD video
- Clock and data recovery
- FPGA/ASIC clock generation

Description

The Si533 dual frequency XO utilizes Silicon Laboratories' advanced DSPLL® circuitry to provide a low jitter clock at high frequencies. The Si533 is available with any-frequency output frequency from 10 to 945 MHz and select frequencies to 1400 MHz. Unlike a traditional XO, where a different crystal is required for each output frequency, the Si533 uses one fixed crystal to provide a wide range of output frequencies. This IC based approach allows the crystal resonator to provide exceptional frequency stability and reliability. In addition, DSPLL clock synthesis provides superior supply noise rejection, simplifying the task of generating low jitter clocks in noisy environments typically found in communication systems. The Si533 IC based XO is factory configurable for a wide variety of user specifications including frequency, supply voltage, output format, and temperature stability. Specific configurations are factory programmed at time of shipment, thereby eliminating long lead times associated with custom oscillators.

Functional Block Diagram



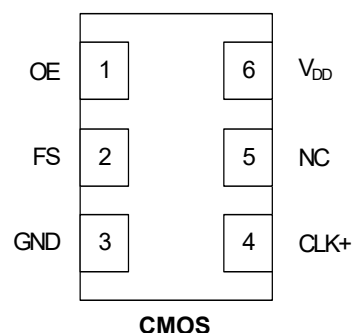
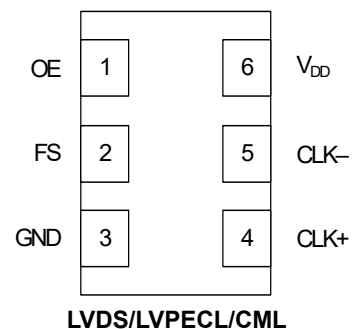
Ordering Information:

See page 7.

Pin Assignments:

See page 6.

(Top View)



1. Electrical Specifications

Table 1. Recommended Operating Conditions

Parameter	Symbol	Test Condition	Min	Typ	Max	Units
Supply Voltage ¹	V_{DD}	3.3 V option	2.97	3.3	3.63	V
		2.5 V option	2.25	2.5	2.75	V
		1.8 V option	1.71	1.8	1.89	V
Supply Current	I_{DD}	Output enabled LVPECL	—	111	121	mA
		CML	—	99	108	
		LVDS	—	90	98	
		CMOS	—	81	88	
		Tristate mode	—	60	75	mA
Output Enable (OE) and Frequency Select (FS) ²		V_{IH}	$0.75 \times V_{DD}$	—	—	V
		V_{IL}	—	—	0.5	V
Operating Temperature Range	T_A		–40	—	85	°C
Notes: - Selectable parameter specified by part number. See Section 3. "Ordering Information" on page 7 for further details. - OE and FS pins include a 17 kΩ pullup resistor to V_{DD}.						

Table 2. CLK± Output Frequency Characteristics

Parameter	Symbol	Test Condition	Min	Typ	Max	Units
Nominal Frequency ^{1,2}	f _O	LVPECL/LVDS/CML	10	—	945	MHz
		CMOS	10	—	160	MHz
Initial Accuracy	f _i	Measured at +25 °C at time of shipping	—	±1.5	—	ppm
Temperature Stability ^{1,3}			–7	—	+7	ppm
			–20	—	+20	
			–50	—	+50	
Aging	f _a	Frequency drift over first year	—	—	±3	ppm
		Frequency drift over 20 year life	—	—	±10	ppm
Notes: 1. See Section 3. "Ordering Information" on page 7 for further details. 2. Specified at time of order by part number. Also available in frequencies from 970 to 1134 MHz and 1213 to 1417 MHz. 3. Selectable parameter specified by part number. 4. Time from powerup or tristate mode to f _O .						

Table 2. CLK± Output Frequency Characteristics (Continued)

Parameter	Symbol	Test Condition	Min	Typ	Max	Units
Total Stability		Temp stability = ± 7 ppm	—	—	± 20	ppm
		Temp stability = ± 20 ppm	—	—	± 31.5	ppm
		Temp stability = ± 50 ppm	—	—	± 61.5	ppm
Powerup Time ⁴	t_{OSC}		—	—	10	ms
Settling Time After FS Change	t_{FRQ}		—	—	10	ms
Notes: 1. See Section 3. "Ordering Information" on page 7 for further details. 2. Specified at time of order by part number. Also available in frequencies from 970 to 1134 MHz and 1213 to 1417 MHz. 3. Selectable parameter specified by part number. 4. Time from powerup or tristate mode to f_O.						

Table 3. CLK± Output Levels and Symmetry

Parameter	Symbol	Test Condition	Min	Typ	Max	Units
LVPECL Output Option ¹	V_O	mid-level	$V_{DD} - 1.42$	—	$V_{DD} - 1.25$	V
	V_{OD}	swing (diff)	1.1	—	1.9	V_{PP}
	V_{SE}	swing (single-ended)	0.55	—	0.95	V_{PP}
LVDS Output Option ²	V_O	mid-level	1.125	1.20	1.275	V
	V_{OD}	swing (diff)	0.5	0.7	0.9	V_{PP}
CML Output Option ²	V_O	2.5/3.3 V option mid-level	—	$V_{DD} - 1.30$	—	V
		1.8 V option mid-level	—	$V_{DD} - 0.36$	—	V
	V_{OD}	2.5/3.3 V option swing (diff)	1.10	1.50	1.90	V_{PP}
		1.8 V option swing (diff)	0.35	0.425	0.50	V_{PP}
CMOS Output Option ³	V_{OH}	$I_{OH} = 32$ mA	$0.8 \times V_{DD}$	—	V_{DD}	V
	V_{OL}	$I_{OL} = 32$ mA	—	—	0.4	V
Rise/Fall time (20/80%)	t_R, t_F	LVPECL/LVDS/CML	—	—	350	ps
		CMOS with $C_L = 15$ pF	—	1	—	ns
Symmetry (duty cycle)	SYM	LVPECL: $V_{DD} - 1.3$ V (diff) LVDS: 1.25 V (diff) CMOS: $V_{DD}/2$	45	—	55	%
Notes: 1. 50Ω to $V_{DD} - 2.0$ V. 2. $R_{term} = 100 \Omega$ (differential). 3. $C_L = 15$ pF						

Table 4. CLK± Output Phase Jitter

Parameter	Symbol	Test Condition	Min	Typ	Max	Units
Phase Jitter (RMS) ¹ for F _{OUT} ≥ 500 MHz	ϕ _J	12 kHz to 20 MHz (OC-48)	—	0.25	0.40	ps
		50 kHz to 80 MHz (OC-192)	—	0.26	0.37	ps
Phase Jitter (RMS) ¹ for F _{OUT} of 125 to 500 MHz	ϕ _J	12 kHz to 20 MHz (OC-48)	—	0.36	0.50	ps
		50 kHz to 80 MHz (OC-192) ²	—	0.34	0.42	ps
Phase Jitter (RMS) for F _{OUT} of 10 to 160 MHz CMOS Output Only	ϕ _J	12 kHz to 20 MHz (OC-48) ²	—	0.62	—	ps
		50 kHz to 20 MHz ²	—	0.61	—	ps
Notes: 1. Refer to AN256 for further information. 2. Max offset frequencies: 80 MHz for F _{OUT} ≥ 250 MHz, 20 MHz for 50 MHz ≤ F _{OUT} <250 MHz, 2 MHz for 10 MHz ≤ F _{OUT} <50 MHz.						

Table 5. CLK± Output Period Jitter

Parameter	Symbol	Test Condition	Min	Typ	Max	Units
Period Jitter*	J _{PER}	RMS	—	2	—	ps
		Peak-to-Peak	—	14	—	ps
*Note: Any output mode, including CMOS, LVPECL, LVDS, CML. N = 1000 cycles. Refer to AN279 for further information.						

Table 6. CLK± Output Phase Noise (Typical)

Offset Frequency (f)	120.00 MHz LVDS	156.25 MHz LVPECL	622.08 MHz LVPECL	Units
100 Hz	−112	−105	−97	dBc/Hz
1 kHz	−122	−122	−107	
10 kHz	−132	−128	−116	
100 kHz	−137	−135	−121	
1 MHz	−144	−144	−134	
10 MHz	−150	−147	−146	
100 MHz	n/a	n/a	−148	

Table 7. Environmental Compliance

The Si533 meets the following qualification test requirements.

Parameter	Conditions/Test Method
Mechanical Shock	MIL-STD-883, Method 2002
Mechanical Vibration	MIL-STD-883, Method 2007
Solderability	MIL-STD-883, Method 2003
Gross & Fine Leak	MIL-STD-883, Method 1014
Resistance to Solder Heat	MIL-STD-883, Method 2036
Moisture Sensitivity Level	J-STD_020, MSL1
Contact Pads	Gold over Nickel

Table 8. Thermal Characteristics

(Typical values $T_A = 25\text{ }^{\circ}\text{C}$, $V_{DD} = 3.3\text{ V}$)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Thermal Resistance Junction to Ambient	θ_{JA}	Still Air	—	84.6	—	$^{\circ}\text{C/W}$
Thermal Resistance Junction to Case	θ_{JC}	Still Air	—	38.8	—	$^{\circ}\text{C/W}$
Ambient Temperature	T_A		-40	—	85	$^{\circ}\text{C}$
Junction Temperature	T_J		—	—	125	$^{\circ}\text{C}$

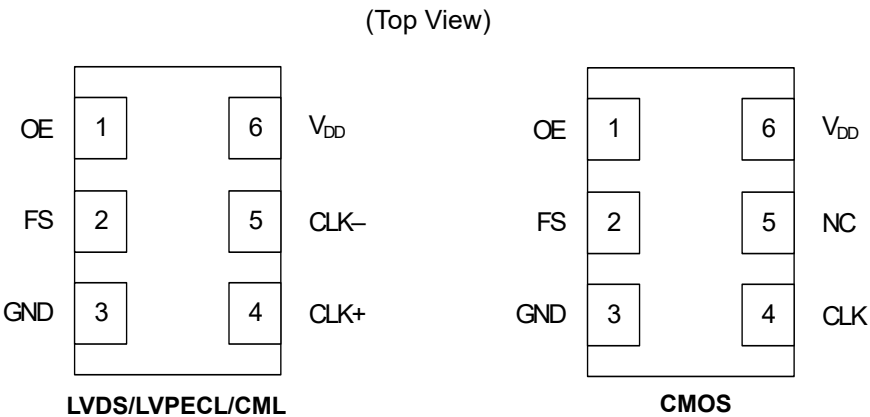
Table 9. Absolute Maximum Ratings¹

Parameter	Symbol	Rating	Units
Maximum Operating Temperature	T_{AMAX}	85	$^{\circ}\text{C}$
Supply Voltage, 1.8 V Option	V_{DD}	-0.5 to +1.9	V
Supply Voltage, 2.5/3.3 V Option	V_{DD}	-0.5 to +3.8	V
Input Voltage (any input pin)	V_I	-0.5 to $V_{DD} + 0.3$	V
Storage Temperature	T_S	-55 to +125	$^{\circ}\text{C}$
ESD Sensitivity (HBM, per JESD22-A114)	ESD	2500	V
Soldering Temperature (Pb-free profile) ²	T_{PEAK}	260	$^{\circ}\text{C}$
Soldering Temperature Time @ T_{PEAK} (Pb-free profile) ²	t_P	20–40	seconds

Notes:

- Stresses beyond those listed in Absolute Maximum Ratings may cause permanent damage to the device. Functional operation or specification compliance is not implied at these conditions. Exposure to maximum rating conditions for extended periods may affect device reliability.
- The device is compliant with JEDEC J-STD-020C. Refer to Si5xx Packaging FAQ available for download at www.silabs.com/VCXO for further information, including soldering profiles.

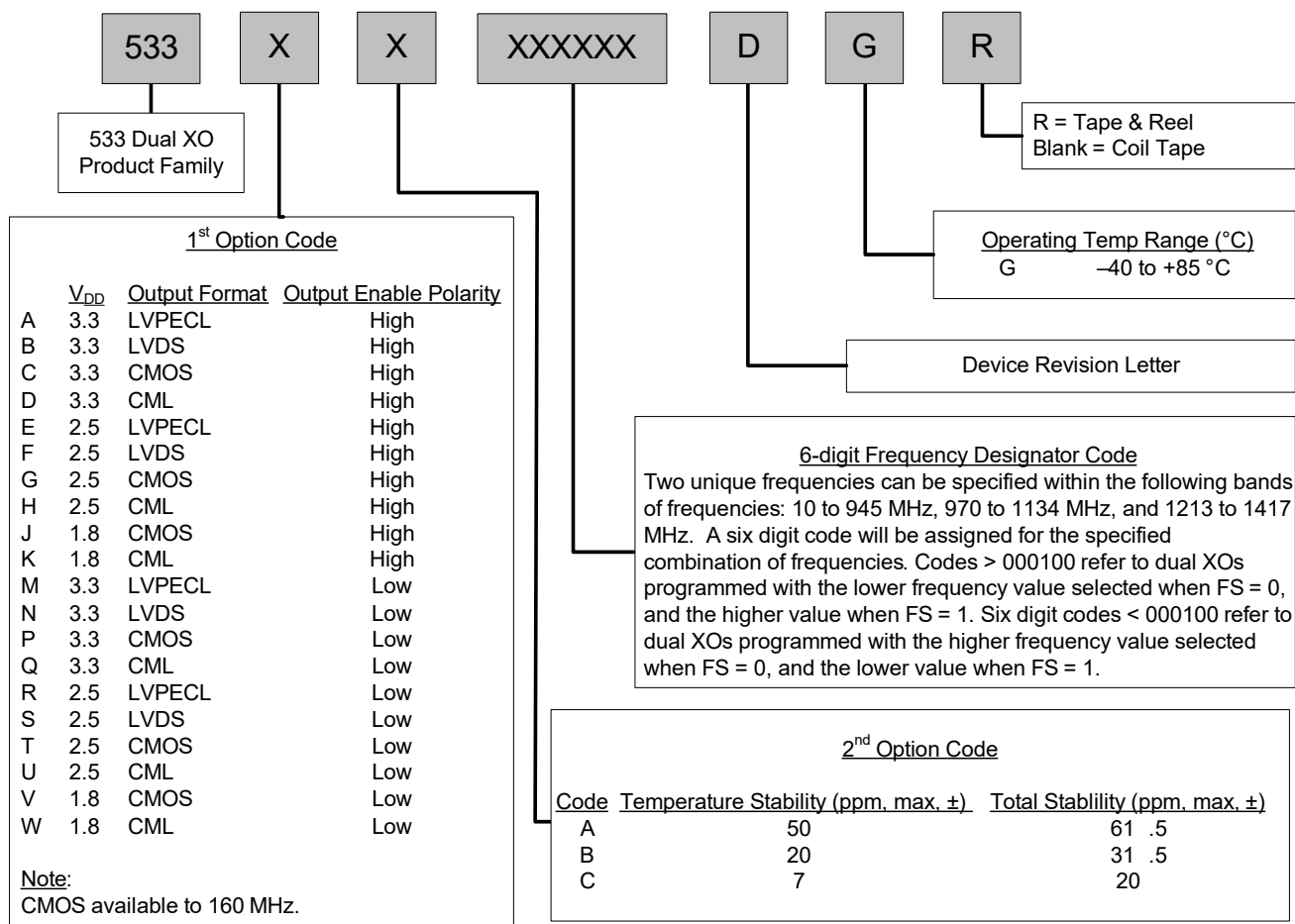
2. Pin Descriptions



Pin #	Symbol	LVDS/LVPECL/CML Function	CMOS Function
1	OE*	Output Enable* 0 = clock output disabled (outputs tristated) 1 = clock output enabled	Output Enable* 0 = clock output disabled (outputs tristated) 1 = clock output enabled
2	FS*	Frequency Select* 0 = First frequency selected 1 = Second frequency selected	Frequency Select* 0 = First frequency selected 1 = Second frequency selected
3	GND	Electrical and Case Ground	Electrical and Case Ground
4	CLK+	Oscillator Output	Oscillator Output
5	CLK-	Complementary Output	No Connection
6	V _{DD}	Power Supply Voltage	Power Supply Voltage
*Note: FS and OE include a 17 kΩ pullup resistor to V _{DD} . See Section 3. "Ordering Information" on page 7 for details on frequency value ordering.			

3. Ordering Information

The Si533 XO supports a variety of options including frequency, temperature stability, output format, and V_{DD} . Specific device configurations are programmed into the Si533 at time of shipment. Configurations can be specified using the Part Number Configuration chart below. Silicon Laboratories provides a web browser-based part number configuration utility to simplify this process. Refer to www.silabs.com/VCXOPartNumber to access this tool and for further ordering instructions. The Si533 is supplied in an industry-standard, RoHS compliant, 6-pad, 5 x 7 mm package. The Si533 supports output enable (OE) on pin 1.



Example Part Number: 533AB000108DGR is a 5x7mm Dual XO in a 6 pad package. Since the six digit code (000108) is > 000100, f₀ is 644.53125 MHz (lower frequency) and f₁ is 693.48299 (higher frequency), with a 3.3V supply and LVPECL output. Temperature stability is specified as ± 20 ppm. The part is specified for a -40 to +85 °C ambient temperature range operation and is shipped in tape and reel format.

Figure 1. Part Number Convention

4. Outline Diagram and Suggested Pad Layout

Figure 2 illustrates the package details for the Si533. Table 10 lists the values for the dimensions shown in the illustration.

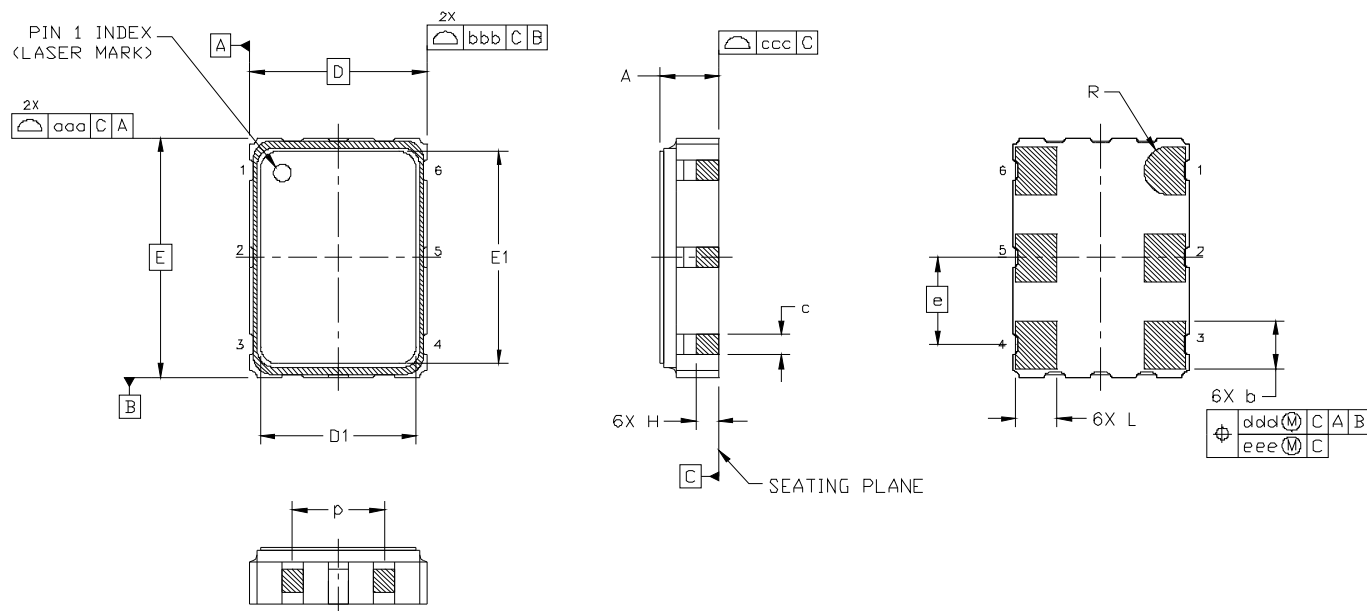


Figure 2. Si533 Outline Diagram

Table 10. Package Diagram Dimensions (mm)

Dimension	Min	Nom	Max
A	1.50	1.65	1.80
b	1.30	1.40	1.50
c	0.50	0.60	0.70
D	5.00 BSC		
D1	4.30	4.40	4.50
e	2.54 BSC		
E	7.00 BSC		
E1	6.10	6.20	6.30
H	0.55	0.65	0.75
L	1.17	1.27	1.37
p	1.80	—	2.60
R	0.70 REF		
aaa	0.15		
bbb	0.15		
ccc	0.10		
ddd	0.10		
eee	0.05		

5. Si533 Mark Specification

Figure 3 illustrates the mark specification for the Si533. Table 11 lists the line information.

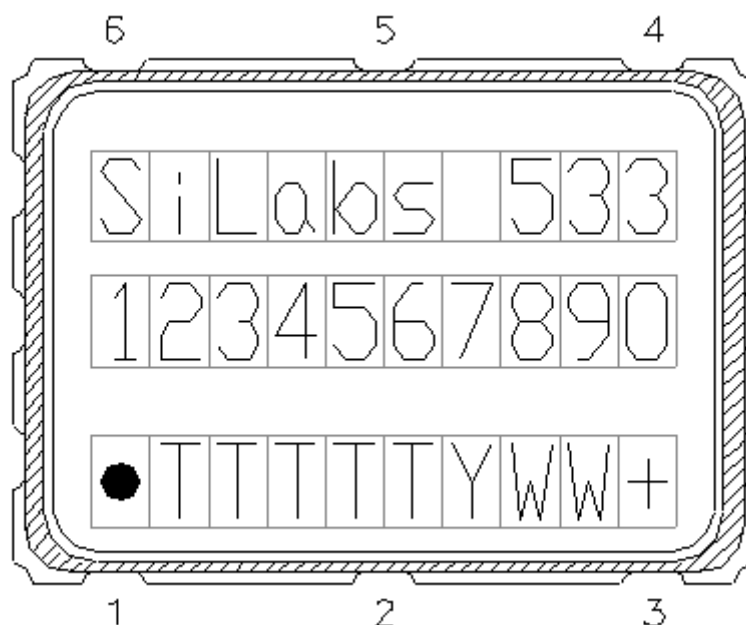


Figure 3. Mark Specification

Table 11. Si53x Top Mark Description

Line	Position	Description
1	1–10	“SiLabs 533”
2	1–10	Si533: Option1 + Option2 + ConfigNum(6) + Temp
3	Trace Code	
	Position 1	Pin 1 orientation mark (dot)
	Position 2	Product Revision (D)
	Position 3–6	Tiny Trace Code (4 alphanumeric characters per assembly release instructions)
	Position 7	Year (least significant year digit), to be assigned by assembly site (ex: 2007 = 7)
	Position 8–9	Calendar Work Week number (1–53), to be assigned by assembly site
	Position 10	“+” to indicate Pb-Free and RoHS-compliant

6. 6-Pin PCB Land Pattern

Figure 4 illustrates the 6-pin PCB land pattern for the Si533. Table 12 lists the values for the dimensions shown in the illustration.

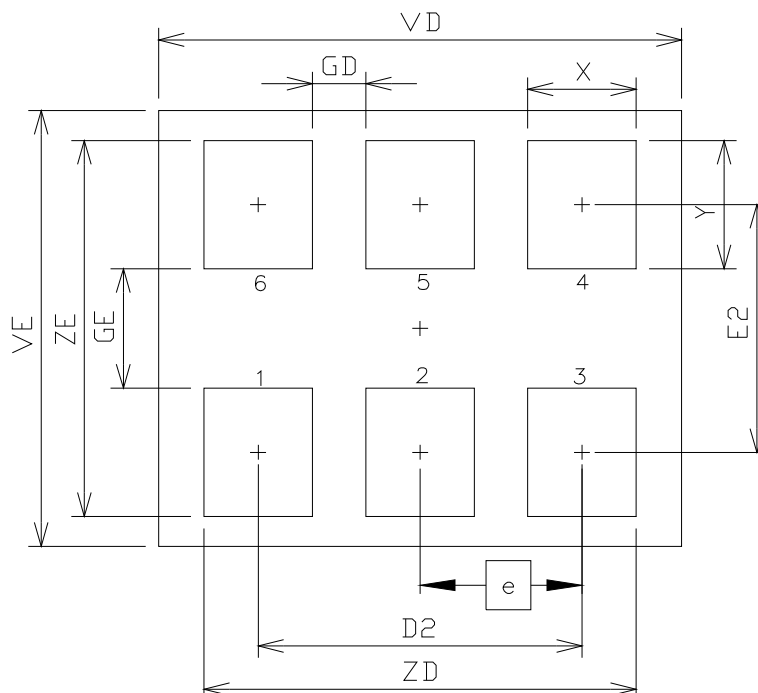


Figure 4. Si533 PCB Land Pattern

Table 12. PCB Land Pattern Dimensions (mm)

Dimension	Min	Max
D2	5.08 REF	
e	2.54 BSC	
E2	4.15 REF	
GD	0.84	—
GE	2.00	—
VD	8.20 REF	
VE	7.30 REF	
X	1.70 TYP	
Y	2.15 REF	
ZD	—	6.78
ZE	—	6.30
Notes:		
1. Dimensioning and tolerancing per the ANSI Y14.5M-1994 specification.		
2. Land pattern design based on IPC-7351 guidelines.		
3. All dimensions shown are at maximum material condition (MMC).		
4. Controlling dimension is in millimeters (mm).		

DOCUMENT CHANGE LIST

Revision 1.0 to Revision 1.1

- Updated Table 1, "Recommended Operating Conditions," on page 2.
 - Device maintains stable operation over –40 to +85 °C operating temperature range.
 - Supply current specifications updated for revision D.
- Updated Table 2, "CLK± Output Frequency Characteristics," on page 2.
 - Added specification for ±20 ppm lifetime stability (±7 ppm temperature stability) XO.
- Updated Table 3, "CLK± Output Levels and Symmetry," on page 3.
 - Updated LVDS differential peak-peak swing specifications.
- Updated Table 4, "CLK± Output Phase Jitter," on page 4.
- Updated Table 5, "CLK± Output Period Jitter," on page 4.
 - Revised period jitter specifications.
- Updated Table 9, "Absolute Maximum Ratings¹," on page 5 to reflect the soldering temperature time at 260 °C is 20–40 sec per JEDEC J-STD-020C.
- Updated 3. "Ordering Information" on page 7.
 - Changed ordering instructions to revision D.
- Added 5. "Si533 Mark Specification" on page 9.

Revision 1.1 to Revision 1.2

- Updated 2.5 V/3.3 V and 1.8 V CML output level specifications for Table 3 on page 3.
- Added footnotes clarifying max offset frequency test conditions for Table 4 on page 4.
- Removed the words "Differential Modes: LVPECL/LVDS/CML" in the footnote referring to AN256 in Table 4 on page 4.
- Added CMOS phase jitter specs to Table 4 on page 4.
- Updated Table 7 on page 5 to include the "Moisture Sensitivity Level" and "Contact Pads" rows.
- Revised Figure 2 on page 8 to reflect current package outline diagram.
- Updated Figure 3 and Table 11 on page 9 to reflect specific marking information. Previously, Figure 3 was generic.
- Updated contact information on page 12.

Revision 1.2 to Revision 1.3

- Added Table 8, "Thermal Characteristics," on page 5.

Revision 1.3 to Revision 1.4

June, 2018

- Changed "Trays" to "Coil Tape" in section 3. "Ordering Information".

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